

+2.7V to +5.25V, Low-Power, 8-Channel, Serial 10-Bit ADCs

General Description

The MAX148/MAX149 10-bit data-acquisition systems combine an 8-channel multiplexer, high-bandwidth track/hold, and serial interface with high conversion speed and low power consumption. They operate from a single +2.7V to +5.25V supply, and sample to 133ksps. Both devices' analog inputs are software configurable for unipolar/bipolar and single-ended/differential operation.

The 4-wire serial interface connects directly to SPI™/QSPI™ and MICROWIRE™ devices without external logic. A serial-strobe output allows direct connection to TMS320-family digital signal processors. The MAX148/MAX149 use either the internal clock or an external serial-interface clock to perform successive-approximation analog-to-digital conversions.

The MAX149 has an internal 2.5V reference, while the MAX148 requires an external reference. Both parts have a reference-buffer amplifier with a $\pm 1.5\%$ voltage-adjustment range.

These devices provide a hard-wired SHDN pin and a software-selectable power-down, and can be programmed to automatically shut down at the end of a conversion. Accessing the serial interface automatically powers up the MAX148/MAX149, and the quick turn-on time allows them to be shut down between all conversions. This technique can cut supply current to under 60µA at reduced sampling rates.

The MAX148/MAX149 are available in a 20-pin DIP and a 20-pin SSOP.

For 4-channel versions of these devices, see the MAX1248/MAX1249 data sheet.

_Applications

Portable Data Logging Data Acquisition

Medical Instruments Battery-Powered Instruments

Pen Digitizers Process Control

Features

- ♦ 8-Channel Single-Ended or 4-Channel Differential Inputs
- ♦ Single-Supply Operation: +2.7V to +5.25V
- ♦ Internal 2.5V Reference (MAX149)
- Low Power: 1.2mA (133ksps, 3V supply)

54μA (1ksps, 3V supply) 1μA (power-down mode)

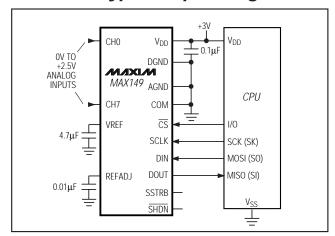
- SPI/QSPI/MICROWIRE/TMS320-Compatible 4-Wire Serial Interface
- **♦** Software-Configurable Unipolar or Bipolar Inputs
- ♦ 20-Pin DIP/SSOP Packages

Ordering Information

PART [†]	TEMP. RANGE	PIN-PACKAGE	INL (LSB)
MAX148ACPP	0°C to +70°C	20 Plastic DIP	±1/2
MAX148BCPP	0°C to +70°C	20 Plastic DIP	±1
MAX148ACAP	0°C to +70°C	20 SSOP	±1/2
MAX148BCAP	0°C to +70°C	20 SSOP	±1

Ordering Information continued at end of data sheet.

Typical Operating Circuit



Pin Configuration appears at end of data sheet.

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[†] Contact factory for availability of alternate surface-mount packages.

ABSOLUTE MAXIMUM RATINGS

V _{DD} to AGND, DGND0. AGND to DGND0.3\	
CH0-CH7, COM to AGND, DGND0.3V to (V _{DD}	
VREF, REFADJ to AGND	+ 0.3V
Digital Inputs to DGND0.	3V to 6V
Digital Outputs to DGND0.3V to (V _{DD}	+ 0.3V
Digital Output Sink Current	25mA
Continuous Power Dissipation ($T_A = +70$ °C)	
Plastic DIP (derate 11.11mW/°C above +70°C)	889mW

SSOP (derate 8.00mW/°C above +7	0°C) 640mW
CERDIP (derate 11.11mW/°C above	+70°C)889mW
Operating Temperature Ranges	
MAX148_C_P/MAX149_C_P	0°C to +70°C
MAX148_E_P/MAX149_E_P	40°C to +85°C
MAX148_MJP/MAX149_MJP	55°C to +125°C
Storage Temperature Range	60°C to +150°C
Lead Temperature (soldering, 10sec).	+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 V_{DD} = +2.7V to +5.25V; COM = 0V; f_{SCLK} = 2.0MHz; external clock (50% duty cycle); 15 clocks/conversion cycle (133ksps); MAX149—4.7µF capacitor at VREF pin; MAX148—external reference, VREF = 2.500V applied to VREF pin; T_A = T_{MIN} to T_{MAX} ; unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
DC ACCURACY (Note 1)	•	1	ı			
Resolution			10			Bits
Relative Accuracy (Note 2)	INL	MAX14_A			±0.5	- LSB
Relative Accuracy (Note 2)	IINL	MAX14_B			±1.0	LSD
Differential Nonlinearity	DNL	No missing codes over temperature			±1	LSB
Offset Error		MAX14_A		±0.15	±1	- LSB
Oliset Lifti		MAX14_B		±0.15	±2	LJD
Gain Error (Note 3)		MAX14_A			±1	LSB
Gain Error (Note 3)		MAX14_B			±2	
Gain Temperature Coefficient				±0.25		ppm/°C
Channel-to-Channel Offset Matching				±0.05		LSB
DYNAMIC SPECIFICATIONS (10)	Hz sine-wa	ve input, 0V to 2.500Vp-p, 133ksps, 2.0MHz exte	rnal clock,	bipolar i	nput mod	de)
Signal-to-Noise + Distortion Ratio	SINAD			66		dB
Total Harmonic Distortion	THD	Up to the 5th harmonic		-70		dB
Spurious-Free Dynamic Range	SFDR			70		dB
Channel-to-Channel Crosstalk		65kHz, 2.500V _{p-p} (Note 4)		-75		dB
Small-Signal Bandwidth		-3dB rolloff		2.25		MHz
Full-Power Bandwidth				1.0		MHz
CONVERSION RATE	•		ı			1
		Internal clock, SHDN = FLOAT	5.5		7.5	
Conversion Time (Note 5)	tconv	Internal clock, SHDN = V _{DD}	35		65	μs
		External clock = 2MHz, 12 clocks/conversion	6			
Track/Hold Acquisition Time	tacq				1.5	μs
Aperture Delay				30		ns
Aperture Jitter	1			<50		+

ELECTRICAL CHARACTERISTICS (continued)

 V_{DD} = +2.7V to +5.25V; COM = 0V; f_{SCLK} = 2.0MHz; external clock (50% duty cycle); 15 clocks/conversion cycle (133ksps); MAX149—4.7µF capacitor at VREF pin; MAX148—external reference, VREF = 2.500 V applied to VREF pin; T_A = T_{MIN} to T_{MAX} ; unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
CONVERSION RATE (continued)	L					1
Internal Clask Fraguency		SHDN = FLOAT		1.8		NAL I =
Internal Clock Frequency		SHDN = V _{DD}		0.225		MHz
External Clack Fraguency			0.1		2.0	MHz
External Clock Frequency		Data transfer only	0		2.0	IVITZ
ANALOG/COM INPUTS						
Input Voltage Range, Single-		Unipolar, COM = 0V		0	to VREF	V
Ended and Differential (Note 6)		Bipolar, COM = VREF / 2		±	VREF/2]
Multiplexer Leakage Current		On/off leakage current, V _{CH} __ = 0V or V _{DD}		±0.01	±1	μΑ
Input Capacitance				16		pF
INTERNAL REFERENCE (MAX14	9 only, refer	rence buffer enabled)	•			
VREF Output Voltage		$T_A = +25$ °C (Note 7)	2.470	2.500	2.530	V
VREF Short-Circuit Current					30	mA
VREF Temperature Coefficient		MAX149		±30		ppm/°C
Load Regulation (Note 8)		0mA to 0.2mA output load		0.35		mV
Capacitive Bypass at VREF		Internal compensation mode	0			
Capacilive bypass at VREF		External compensation mode	4.7			μF
Capacitive Bypass at REFADJ			0.01			μF
REFADJ Adjustment Range				±1.5		%
EXTERNAL REFERENCE AT VR	F (Buffer d	isabled)	'			1
VREF Input Voltage Range (Note 9)			1.0		V _{DD} + 50mV	V
VREF Input Current		VREF = 2.500V		100	150	μΑ
VREF Input Resistance			18	25		kΩ
Shutdown VREF Input Current				0.01	10	μΑ
REFADJ Buffer-Disable Threshold			V _{DD} - 0.5			V
EXTERNAL REFERENCE AT REF	ADJ					1
0		Internal compensation mode	0			_
Capacitive Bypass at VREF		External compensation mode	4.7			μF
Defenses Duffer O		MAX149		2.06		1/0/
Reference Buffer Gain		MAX148		2.00		V/V
DEFAD Harrist Co.		MAX149			±50	
REFADJ Input Current		MAX148			±10	μΑ
		1				1



ELECTRICAL CHARACTERISTICS (continued)

 V_{DD} = +2.7V to +5.25V; COM = 0V; f_{SCLK} = 2.0MHz; external clock (50% duty cycle); 15 clocks/conversion cycle (133ksps); MAX149—4.7µF capacitor at VREF pin; MAX148—external reference, VREF = 2.500V applied to VREF pin; T_A = T_{MIN} to T_{MAX} ; unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIO	MIN	TYP	MAX	UNITS	
DIGITAL INPUTS (DIN, SCLK, CS	SHDN)						
DIN COLV OC Input High Valtage	\/	V _{DD} ≤ 3.6V		2.0			V
DIN, SCLK, CS Input High Voltage	VIH	V _{DD} > 3.6V		3.0]
DIN, SCLK, CS Input Low Voltage	V _{IL}					0.8	V
DIN, SCLK, CS Input Hysteresis	VHYST				0.2		V
DIN, SCLK, CS Input Leakage	I _{IN}	V _{IN} = 0V or V _{DD}			±0.01	±1	μA
DIN, SCLK, CS Input Capacitance	CIN	(Note 10)				15	pF
SHDN Input High Voltage	V _{SH}			V _{DD} - 0.4			V
SHDN Input Mid Voltage	V _{SM}			1.1	V	_{DD} - 1.1	V
SHDN Input Low Voltage	V _{SL}					0.4	V
SHDN Input Current	IS	SHDN = 0V or V _{DD}				±4.0	μΑ
SHDN Voltage, Floating	V _{FL} T	SHDN = FLOAT			V _{DD} /2		V
SHDN Maximum Allowed		SHDN = FLOAT				±100	nA
Leakage, Mid Input		STIDIN - TEOAT				1100	
DIGITAL OUTPUTS (DOUT, SSTR	B)						
Output Voltage Low	VoL	I _{SINK} = 5mA				0.4	
. 0	VOL	I _{SINK} = 16mA				0.8	v
Output Voltage High	Voн	ISOURCE = 0.5mA		V _{DD} - 0.5			V
Three-State Leakage Current	ΙL	$\overline{\text{CS}} = V_{\text{DD}}$			±0.01	±10	μΑ
Three-State Output Capacitance	Cout	CS = V _{DD} (Note 10)				15	pF
POWER REQUIREMENTS							
Positive Supply Voltage	V _{DD}			2.70		5.25	V
		Operating mode,	$V_{DD} = 5.25V$		1.6	3.0	mA
	I _{DD}	full-scale input (Note 11)	$V_{DD} = 3.6V$		1.2	2.0] "
Positive Supply Current	טטי	Full power-down	V _{DD} = 5.25V		3.5	15	
		$V_{DD} = 3.6V$			1.2	10	μΑ
	I _{DD}	Fast power-down (MAX149)		30	70		
Supply Rejection (Note 12)	PSR	Full-scale input, external ref V _{DD} = 2.7V to 5.25V	ference = 2.500V,		±0.3		mV

* _____ /N/XI/M

TIMING CHARACTERISTICS

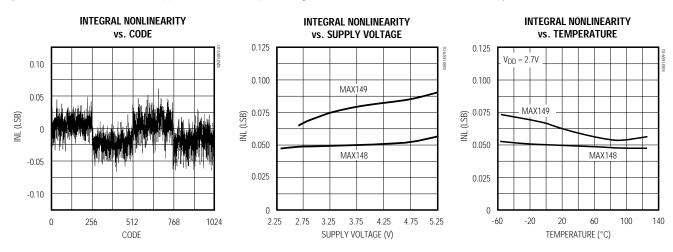
(V_{DD} = +2.7V to +5.25V, T_{A} = T_{MIN} to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL		CONDITIONS	MIN	TYP	MAX	UNITS
Acquisition Time	tACQ			1.5			μs
DIN to SCLK Setup	t _{DS}			100			ns
DIN to SCLK Hold	t _{DH}			0			ns
SCLK Fall to Output Data Valid	too	Figure 1	MAX14C/E	20		200	nc
SCER Fall to Output Data Vallu	t _{DO}	rigule i	MAX14M	20		240	ns
CS Fall to Output Enable	t _{DV}	Figure 1	•			240	ns
CS Rise to Output Disable	t _{TR}	Figure 2				240	ns
CS to SCLK Rise Setup	tcss			100			ns
CS to SCLK Rise Hold	tcsh			0			ns
SCLK Pulse Width High	tсн			200			ns
SCLK Pulse Width Low	t _{CL}			200			ns
SCLK Fall to SSTRB	tsstrb	Figure 1				240	ns
CS Fall to SSTRB Output Enable	tsdv	External cloc	ck mode only, Figure 1			240	ns
CS Rise to SSTRB Output Disable	tstr	External cloc	ck mode only, Figure 2			240	ns
SSTRB Rise to SCLK Rise	tsck	Internal cloc	k mode only (Note 7)	0			ns

- **Note 1:** Tested at $V_{DD} = 2.7V$; COM = 0V; unipolar single-ended input mode.
- **Note 2:** Relative accuracy is the deviation of the analog value at any code from its theoretical value after the full-scale range has been calibrated.
- Note 3: MAX149—internal reference, offset nulled; MAX148—external reference (VREF = +2.500V), offset nulled.
- Note 4: Ground "on" channel; sine wave applied to all "off" channels.
- Note 5: Conversion time defined as the number of clock cycles multiplied by the clock period; clock has 50% duty cycle.
- **Note 6:** The common-mode range for the analog inputs is from AGND to V_{DD} .
- Note 7: Sample tested to 0.1% AQL.
- Note 8: External load should not change during conversion for specified accuracy.
- Note 9: ADC performance is limited by the converter's noise floor, typically 300µVp-p.
- Note 10: Guaranteed by design. Not subject to production testing.
- Note 11: The MAX148 typically draws 400µA less than the values shown.
- **Note 12:** Measured as $|V_{FS}(2.7V) V_{FS}(5.25V)|$.

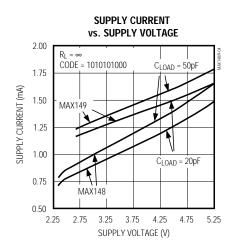
_Typical Operating Characteristics

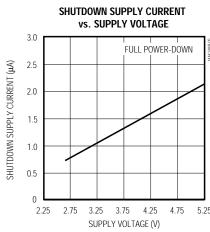
 $(V_{DD} = 3.0V, VREF = 2.500V, f_{SCLK} = 2.0MHz, C_{LOAD} = 20pF, T_{A} = +25^{\circ}C, unless otherwise noted.)$

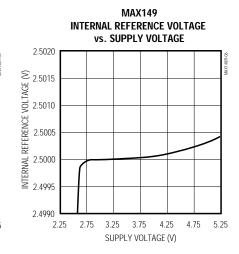


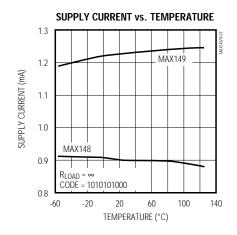
Typical Operating Characteristics (continued)

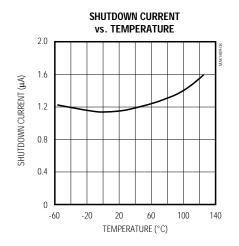
 $(V_{DD} = 3.0V, VREF = 2.500V, f_{SCLK} = 2.0MHz, C_{LOAD} = 20pF, T_{A} = +25^{\circ}C, unless otherwise noted.)$

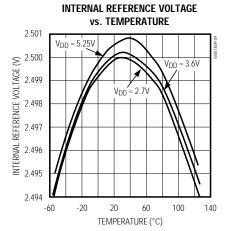












MAX149

Pin Description

PIN	NAME	FUNCTION
1–8	CH0-CH7	Sampling Analog Inputs
9	COM	Ground reference for analog inputs. COM sets zero-code voltage in single-ended mode. Must be stable to ±0.5LSB.
10	SHDN	Three-Level Shutdown Input. Pulling SHDN low shuts the MAX148/MAX149 down; otherwise, they are fully operational. Pulling SHDN high puts the reference-buffer amplifier in internal compensation mode. Letting SHDN float puts the reference-buffer amplifier in external compensation mode.
11	VREF	Reference-Buffer Output/ADC Reference Input. Reference voltage for analog-to-digital conversion. In internal reference mode (MAX149 only), the reference buffer provides a 2.500V nominal output, externally adjustable at REFADJ. In external reference mode, disable the internal buffer by pulling REFADJ to VDD.
12	REFADJ	Input to the Reference-Buffer Amplifier. To disable the reference-buffer amplifier, tie REFADJ to V _{DD} .
13	AGND	Analog Ground
14	DGND	Digital Ground
15	DOUT	Serial-Data Output. Data is clocked out at SCLK's falling edge. High impedance when $\overline{\text{CS}}$ is high.
16	SSTRB	Serial-Strobe Output. In internal clock mode, SSTRB goes low when the MAX148/MAX149 begin the A/D conversion, and goes high when the conversion is finished. In external clock mode, SSTRB pulses high for one clock period before the MSB decision. High impedance when $\overline{\text{CS}}$ is high (external clock mode).
17	DIN	Serial-Data Input. Data is clocked in at SCLK's rising edge.
18	CS	Active-Low Chip Select. Data will not be clocked into DIN unless $\overline{\text{CS}}$ is low. When $\overline{\text{CS}}$ is high, DOUT is high impedance.
19	SCLK	Serial-Clock Input. Clocks data in and out of serial interface. In external clock mode, SCLK also sets the conversion speed. (Duty cycle must be 40% to 60%.)
20	V _{DD}	Positive Supply Voltage

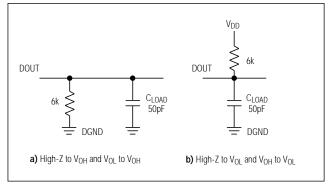


Figure 1. Load Circuits for Enable Time

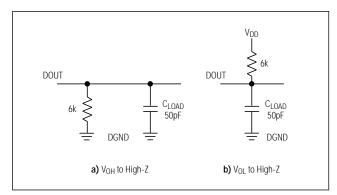


Figure 2. Load Circuits for Disable Time



Detailed Description

The MAX148/MAX149 analog-to-digital converters (ADCs) use a successive-approximation conversion technique and input track/hold (T/H) circuitry to convert an analog signal to a 10-bit digital output. A flexible serial interface provides easy interface to microprocessors (µPs). Figure 3 is a block diagram of the MAX148/MAX149.

Pseudo-Differential Input

The sampling architecture of the ADC's analog comparator is illustrated in the equivalent input circuit (Figure 4). In single-ended mode, IN+ is internally switched to CH0-CH7, and IN- is switched to COM. In differential mode, IN+ and IN- are selected from the following pairs: CH0/CH1, CH2/CH3, CH4/CH5, and CH6/CH7. Configure the channels with Tables 2 and 3.

In differential mode, IN- and IN+ are internally switched to either of the analog inputs. This configuration is pseudo-differential to the effect that only the signal at IN+ is sampled. The return side (IN-) must remain stable within $\pm 0.5 LSB$ ($\pm 0.1 LSB$ for best results) with respect to AGND during a conversion. To accomplish this, connect a $0.1 \mu F$ capacitor from IN- (the selected analog input) to AGND.

During the acquisition interval, the channel selected as the positive input (IN+) charges capacitor C_{HOLD}. The acquisition interval spans three SCLK cycles and ends on the falling SCLK edge after the last bit of the input control word has been entered. At the end of the

acquisition interval, the T/H switch opens, retaining charge on $C_{\mbox{\scriptsize HOLD}}$ as a sample of the signal at IN+.

The conversion interval begins with the input multiplexer switching C_{HOLD} from the positive input (IN+) to the negative input (IN-). In single-ended mode, IN- is simply COM. This unbalances node ZERO at the comparator's input. The capacitive DAC adjusts during the remainder of the conversion cycle to restore node ZERO to 0V within the limits of 10-bit resolution. This action is equivalent to transferring a 16pF x $[(V_{IN+})$ - $(V_{IN-})]$ charge from C_{HOLD} to the binary-weighted capacitive DAC, which in turn forms a digital representation of the analog input signal.

Track/Hold

The T/H enters its tracking mode on the falling clock edge after the fifth bit of the 8-bit control word has been shifted in. It enters its hold mode on the falling clock edge after the eighth bit of the control word has been shifted in. If the converter is set up for single-ended inputs, IN- is connected to COM, and the converter samples the "+" input. If the converter is set up for differential inputs, IN- connects to the "-" input, and the difference of |IN+ - IN-| is sampled. At the end of the conversion, the positive input connects back to IN+, and CHOLD charges to the input signal.

The time required for the T/H to acquire an input signal is a function of how quickly its input capacitance is charged. If the input signal's source impedance is high, the acquisition time lengthens, and more time must be

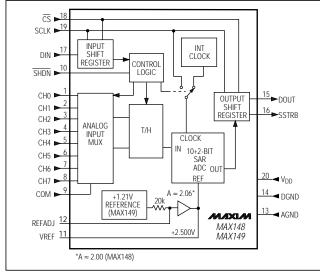


Figure 3. Block Diagram

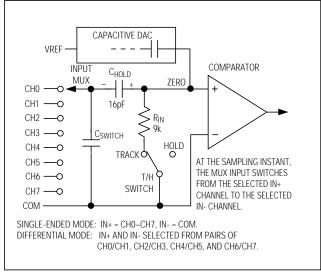


Figure 4. Equivalent Input Circuit

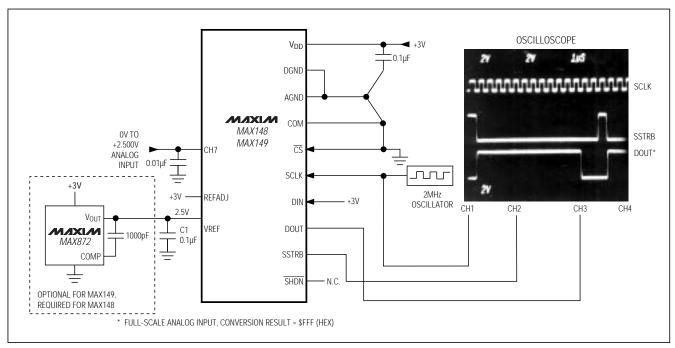


Figure 5. Quick-Look Circuit

allowed between conversions. The acquisition time, t_{ACQ} , is the maximum time the device takes to acquire the signal, and is also the minimum time needed for the signal to be acquired. It is calculated by the following equation:

$$t_{ACQ} = 7 x (R_S + R_{IN}) x 16pF$$

where $R_{IN}=9k\Omega$, $R_S=$ the source impedance of the input signal, and t_{ACQ} is never less than 1.5 μ s. Note that source impedances below $4k\Omega$ do not significantly affect the ADC's AC performance.

Higher source impedances can be used if a $0.01\mu F$ capacitor is connected to the individual analog inputs. Note that the input capacitor forms an RC filter with the input source impedance, limiting the ADC's signal bandwidth.

Input Bandwidth

The ADC's input tracking circuitry has a 2.25MHz small-signal bandwidth, so it is possible to digitize high-speed transient events and measure periodic signals with bandwidths exceeding the ADC's sampling rate by using undersampling techniques. To avoid high-frequency signals being aliased into the frequency band of interest, anti-alias filtering is recommended.

Analog Input Protection

Internal protection diodes, which clamp the analog input to V_{DD} and AGND, allow the channel input pins to swing from AGND - 0.3V to V_{DD} + 0.3V without damage. However, for accurate conversions near full scale, the inputs must not exceed V_{DD} by more than 50mV or be lower than AGND by 50mV.

If the analog input exceeds 50mV beyond the supplies, do not forward bias the protection diodes of off channels over 2mA.

Quick Look

To quickly evaluate the MAX148/MAX149's analog performance, use the circuit of Figure 5. The MAX148/MAX149 require a control byte to be written to DIN before each conversion. Tying DIN to +3V feeds in control bytes of \$FF (HEX), which trigger single-ended unipolar conversions on CH7 in external clock mode without powering down between conversions. In external clock mode, the SSTRB output pulses high for one clock period before the most significant bit of the conversion result is shifted out of DOUT. Varying the analog input to CH7 will alter the sequence of bits from DOUT. A total of 15 clock cycles is required per conversion. All transitions of the SSTRB and DOUT outputs occur on the falling edge of SCLK.

Table 1. Control-Byte Format

BIT 7 (MSB)	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0 (LSB)
START	SEL2	SEL1	SEL0	UNI/BIP	SGL/ DIF	PD1	PD0

BIT	NAME	DESCRIPTION
7(MSB)	START	The first logic "1" bit after $\overline{\text{CS}}$ goes low defines the beginning of the control byte.
6 5 4	SEL2 SEL1 SEL0	These three bits select which of the eight channels are used for the conversion (Tables 2 and 3).
3	UNI/BIP	1 = unipolar, 0 = bipolar. Selects unipolar or bipolar conversion mode. In unipolar mode, an analog input signal from 0V to VREF can be converted; in bipolar mode, the signal can range from -VREF/2 to +VREF/2.
2	SGL/ DIF	1 = single ended, 0 = differential. Selects single-ended or differential conversions. In single-ended mode, input signal voltages are referred to COM. In differential mode, the voltage difference between two channels is measured (Tables 2 and 3).
1	PD1	Selects clock and power-down modes.
0(LSB)	PD0	PD1 PD0 Mode
		0 0 Full power-down 0 1 Fast power-down (MAX149 only)
		1 0 Internal clock mode
		1 1 External clock mode

Table 2. Channel Selection in Single-Ended Mode (SGL/DIF = 1)

SEL2	SEL1	SEL0	CH0	CH1	CH2	CH3	CH4	CH5	CH6	CH7	СОМ
0	0	0	+								-
1	0	0		+							_
0	0	1			+						_
1	0	1				+					_
0	1	0					+				_
1	1	0						+			_
0	1	1							+		-
1	1	1								+	-

How to Start a Conversion

Start <u>a</u> conversion by clocking a control byte into DIN. With $\overline{\text{CS}}$ low, each rising edge on SCLK clocks a bit from DIN into the MAX148/MAX149's internal shift register. After $\overline{\text{CS}}$ falls, the first arriving logic "1" bit defines the control byte's MSB. Until this first "start" bit arrives, any number of logic "0" bits can be clocked into DIN with no effect. Table 1 shows the control-byte format.

The MAX148/MAX149 are compatible with SPI/ QSPI and MICROWIRE devices. For SPI, select the correct clock polarity and sampling edge in the SPI control registers: set CPOL = 0 and CPHA = 0. MICROWIRE, SPI, and QSPI all transmit a byte and receive a byte at the same time. Using the *Typical Operating Circuit*, the simplest software interface requires only three 8-bit transfers to perform a conversion (one 8-bit transfer to configure the ADC, and two more 8-bit transfers to clock out the conversion result). See Figure 20 for MAX148/MAX149 QSPI connections.

Table 3. Channel Selection in Differential Mode (SGL/ $\overline{DIF} = 0$)

SEL2	SEL1	SEL0	CH0	CH1	CH2	СНЗ	CH4	CH5	CH6	CH7
0	0	0	+	-						
0	0	1			+	-				
0	1	0					+	-		
0	1	1							+	-
1	0	0	-	+						
1	0	1			-	+				
1	1	0					-	+		
1	1	1							-	+

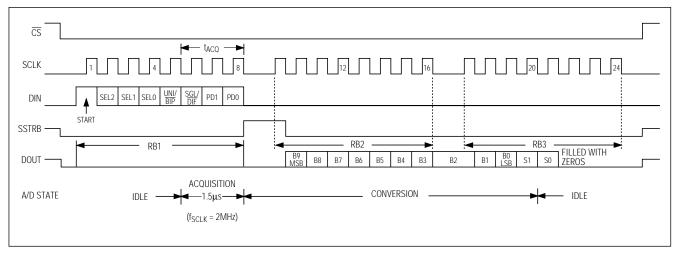


Figure 6. 24-Clock External Clock Mode Conversion Timing (MICROWIRE and SPI-Compatible, QSPI-Compatible with fSCI K ≤ 2MHz)

Simple Software Interface

Make sure the CPU's serial interface runs in master mode so the CPU generates the serial clock. Choose a clock frequency from 100kHz to 2MHz.

- Set up the control byte for external clock mode and call it TB1. TB1 should be of the format: 1XXXXX11 binary, where the Xs denote the particular channel and conversion mode selected.
- 2) Use a general-purpose I/O line on the CPU to pull CS low.
- 3) Transmit TB1 and, simultaneously, receive a byte and call it RB1. Ignore RB1.
- 4) Transmit a byte of all zeros (\$00 hex) and, simultaneously, receive byte RB2.
- 5) Transmit a byte of all zeros (\$00 hex) and, simultaneously, receive byte RB3.
- 6) Pull CS high.

Figure 6 shows the timing for this sequence. Bytes RB2 and RB3 contain the result of the conversion, padded with one leading zero, two sub-LSB bits, and three trailing zeros. The total conversion time is a function of the serial-clock frequency and the amount of idle time between 8-bit transfers. To avoid excessive T/H droop, make sure the total conversion time does not exceed 120us.

Digital Output

In unipolar input mode, the output is straight binary (Figure 17). For bipolar input mode, the output is twos complement (Figure 18). Data is clocked out at the falling edge of SCLK in MSB-first format.

Clock Modes

The MAX148/MAX149 may use either an external serial clock or the internal clock to perform the successive-approximation conversion. In both clock modes, the external clock shifts data in and out of the

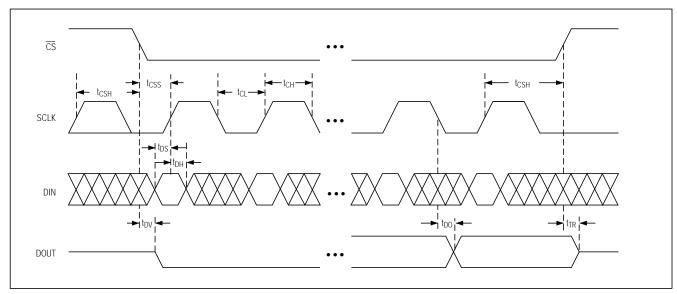


Figure 7. Detailed Serial-Interface Timing

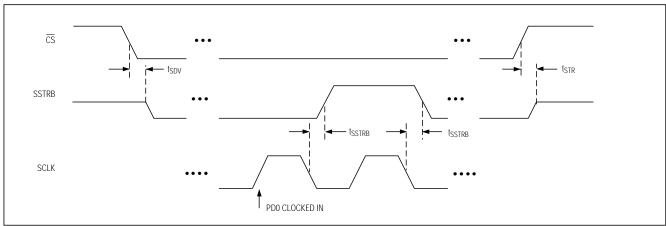


Figure 8. External Clock Mode SSTRB Detailed Timing

MAX148/MAX149. The T/H acquires the input signal as the last three bits of the control byte are clocked into DIN. Bits PD1 and PD0 of the control byte program the clock mode. Figures 7–10 show the timing characteristics common to both modes.

External Clock

In external clock mode, the external clock not only shifts data in and out, but it also drives the analog-to-digital conversion steps. SSTRB pulses high for one clock period after the last bit of the control byte. Successive-approximation bit decisions are made and appear at DOUT on each of the next 12 SCLK falling edges (Figure 6). SSTRB and DOUT go into a high-impedance

state when $\overline{\text{CS}}$ goes high; after the next $\overline{\text{CS}}$ falling edge, SSTRB outputs a logic low. Figure 8 shows the SSTRB timing in external clock mode.

The conversion must complete in some minimum time, or droop on the sample-and-hold capacitors may degrade conversion results. Use internal clock mode if the serial-clock frequency is less than 100kHz, or if serial-clock interruptions could cause the conversion interval to exceed 120µs.

Internal Clock

In internal clock mode, the MAX148/MAX149 generate their own conversion clocks internally. This frees the µP

12 ______ **//| //|**

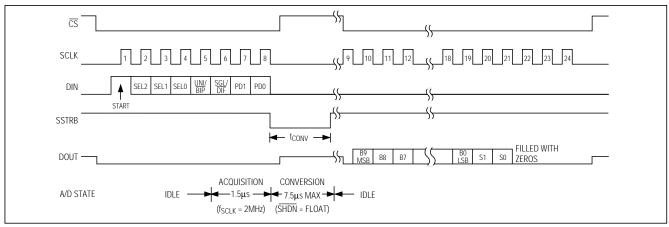


Figure 9. Internal Clock Mode Timing

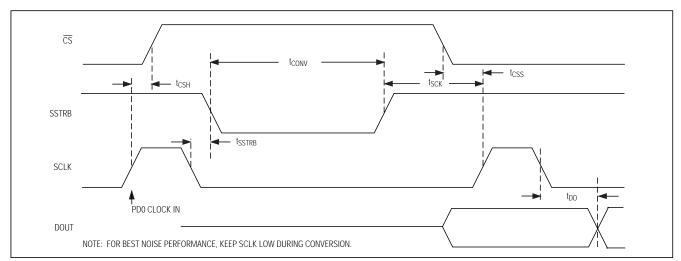


Figure 10. Internal Clock Mode SSTRB Detailed Timing

from the burden of running the SAR conversion clock and allows the conversion results to be read back at the processor's convenience, at any clock rate from 0MHz to 2MHz. SSTRB goes low at the start of the conversion and then goes high when the conversion is complete. SSTRB is low for a maximum of 7.5µs (SHDN = FLOAT), during which time SCLK should remain low for best noise performance.

An internal register stores data when the conversion is in progress. SCLK clocks the data out of this register at any time after the conversion is complete. After SSTRB goes high, the next falling clock edge produces the MSB of the conversion at DOUT, followed by the remaining bits in MSB-first format (Figure 9). CS does not need to be held low once a conversion is started.

Pulling $\overline{\text{CS}}$ high prevents data from being clocked into the MAX148/MAX149 and three-states DOUT, but it does not adversely affect an internal clock mode conversion already in progress. When internal clock mode is selected, SSTRB does not go into a high-impedance state when $\overline{\text{CS}}$ goes high.

Figure 10 shows the SSTRB timing in internal clock mode. In this mode, data can be shifted in and out of the MAX148/MAX149 at clock rates exceeding 2.0MHz if the minimum acquisition time (tACQ) is kept above 1.5µs.

Data Framing

The falling edge of $\overline{\text{CS}}$ does **not** start a conversion. The first logic high clocked into DIN is interpreted as a start bit and defines the first bit of the control byte. A conversion starts on SCLK's falling edge, after the eighth



Table 4. Typical Power-Up Delay Times

REFERENCE BUFFER	REFERENCE- BUFFER COMPENSATION MODE	VREF CAPACITOR (µF)	POWER-DOWN MODE	POWER-UP DELAY (µs)	MAXIMUM SAMPLING RATE (ksps)
Enabled	Internal	_	Fast	5	26
Enabled	Internal	_	Full	300	26
Enabled	External	4.7	Fast	See Figure 14c	133
Enabled	External	4.7	Full	See Figure 14c	133
Disabled	_	_	Fast	2	133
Disabled	_	_	Full	2	133

bit of the control byte (the PDO bit) is clocked into DIN. The start bit is defined as follows:

The first high bit clocked into DIN with CS low any time the converter is idle; e.g., after V_{DD} is applied.

OR

The first high bit clocked into DIN after bit 3 of a conversion in progress is clocked onto the DOUT pin.

If \overline{CS} is toggled before the current conversion is complete, the next high bit clocked into DIN is recognized as a start bit; the current conversion is terminated, and a new one is started.

The fastest the MAX148/MAX149 can run with \overline{CS} held low between conversions is 15 clocks per conversion. Figure 11a shows the serial-interface timing necessary to perform a conversion every 15 SCLK cycles in external clock mode. If $\overline{\text{CS}}$ is tied low and SCLK is continuous, guarantee a start bit by first clocking in 16 zeros.

Most microcontrollers (µCs) require that conversions occur in multiples of 8 SCLK clocks; 16 clocks per conversion is typically the fastest that a μC can drive the MAX148/MAX149. Figure 11b shows the serialinterface timing necessary to perform a conversion every 16 SCLK cycles in external clock mode.

Applications Information

Power-On Reset

When power is first applied, and if SHDN is not pulled low, internal power-on reset circuitry activates the MAX148/MAX149 in internal clock mode, ready to convert with SSTRB = high. After the power supplies stabilize, the internal reset time is 10µs, and no conversions should be performed during this phase. SSTRB is high on power-up and, if CS is low, the first logical 1 on DIN is interpreted as a start bit. Until a conversion takes place, DOUT shifts out zeros. (Also see Table 4.)

Reference-Buffer Compensation

In addition to its shutdown function, SHDN selects internal or external compensation. The compensation affects both power-up time and maximum conversion speed. The 100kHz minimum clock rate is limited by droop on the sample-and-hold and is independent of the compensation used.

Float SHDN to select external compensation. The Typical Operating Circuit uses a 4.7µF capacitor at VREF. A 4.7µF value ensures reference-buffer stability and allows converter operation at the 2MHz full clock speed. External compensation increases power-up time (see the Choosing Power-Down Mode section and Table 4).

Pull SHDN high to select internal compensation. Internal compensation requires no external capacitor at VREF and allows for the shortest power-up times. The maximum clock rate is 2MHz in internal clock mode and 400kHz in external clock mode.

Choosing Power-Down Mode

You can save power by placing the converter in a lowcurrent shutdown state between conversions. Select full power-down mode or fast power-down mode via bits 1 and 0 of the DIN control byte with SHDN high or floating (Tables 1 and 5). In both software power-down modes, the serial interface remains operational, but the ADC does not convert. Pull SHDN low at any time to shut down the converter completely. SHDN overrides bits 1 and 0 of the control byte.

Full power-down mode turns off all chip functions that draw quiescent current, reducing supply current to 2µA (typ). Fast power-down mode turns off all circuitry except the bandgap reference. With fast power-down mode, the supply current is 30µA. Power-up time can be shortened to 5µs in internal compensation mode.

Table 4 shows how the choice of reference-buffer compensation and power-down mode affects both power-up

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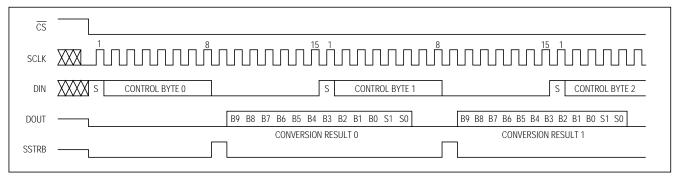


Figure 11a. External Clock Mode, 15 Clocks/Conversion Timing

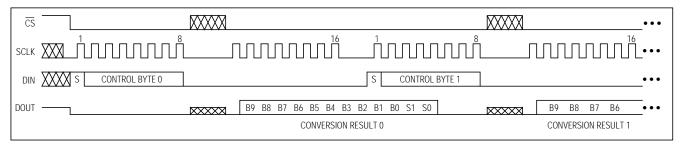


Figure 11b. External Clock Mode, 16 Clocks/Conversion Timing

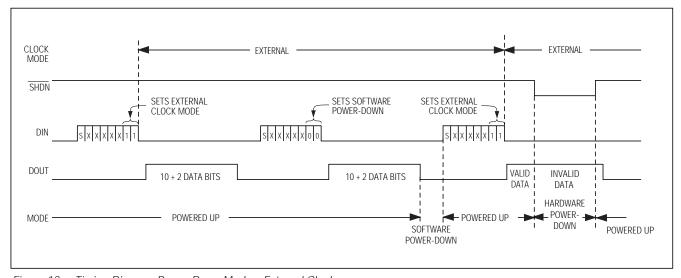


Figure 12a. Timing Diagram Power-Down Modes, External Clock

delay and maximum sample rate. In external compensation mode, power-up time is 20ms with a $4.7\mu F$ compensation capacitor when the capacitor is initially fully discharged. From fast power-down, start-up time can be eliminated by using low-leakage capacitors that do not

discharge more than 1/2LSB while shut down. In power-down, leakage currents at VREF cause droop on the reference bypass capacitor. Figures 12a and 12b show the various power-down sequences in both external and internal clock modes.



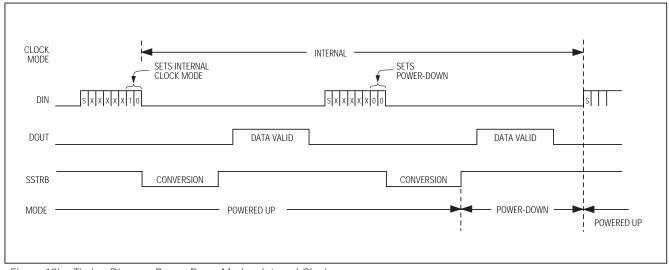


Figure 12b. Timing Diagram Power-Down Modes, Internal Clock

Table 5. Software Power-Down and Clock Mode

PD1	PD0	DEVICE MODE	
0	0	Full Power-Down	
0	1	Fast Power-Down	
1	0	Internal Clock	
1	1	External Clock	

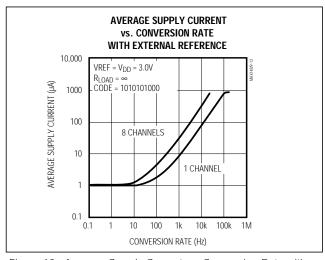


Figure 13. Average Supply Current vs. Conversion Rate with External Reference

Table 6. Hard-Wired Power-Down and Internal Clock Frequency

SHDN STATE	DEVICE MODE	REFERENCE- BUFFER COMPENSATION	INTERNAL CLOCK FREQUENCY
1	Enabled	Internal	225kHz
Floating	Enabled	External	1.8MHz
0	Power-Down	N/A	N/A

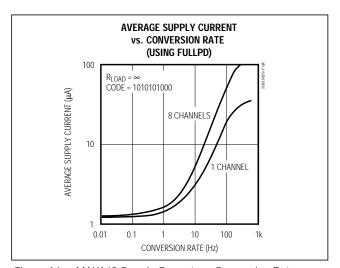


Figure 14a. MAX149 Supply Current vs. Conversion Rate, FULLPD

16 ______ /I/XI/N

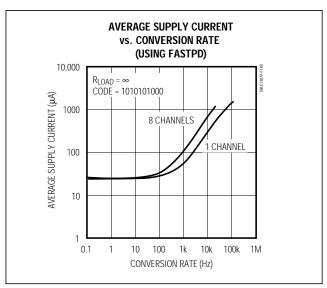


Figure 14b. MAX149 Supply Current vs. Conversion Rate, FASTPD

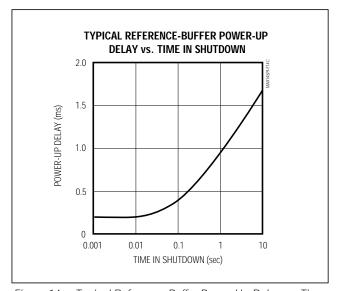


Figure 14c. Typical Reference-Buffer Power-Up Delay vs. Time in Shutdown

Software Power-Down

Software power-down is activated using bits PD1 and PD0 of the control byte. As shown in Table 5, PD1 and PD0 also specify the clock mode. When software shutdown is asserted, the ADC operates in the last specified clock mode until the conversion is complete. Then the ADC powers down into a low quiescent-current state. In internal clock mode, the interface remains active and conversion

results may be clocked out after the MAX148/MAX149 enter a software power-down.

The first logical 1 on DIN is interpreted as a start bit and powers up the MAX148/MAX149. Following the start bit, the data input word or control byte also determines clock mode and power-down states. For example, if the DIN word contains PD1 = 1, then the chip remains powered up. If PD0 = PD1 = 0, a power-down resumes after one conversion.

Hardware Power-Down

Pulling SHDN low places the converter in hardware power-down (Table 6). Unlike software power-down mode, the conversion is not completed; it stops coincidentally with SHDN being brought low. SHDN also controls the clock frequency in internal clock mode. Letting SHDN float sets the internal clock frequency to 1.8MHz. When returning to normal operation with SHDN floating, there is a tRC delay of approximately $2M\Omega$ x CL, where CL is the capacitive loading on the SHDN pin. Pulling SHDN high sets internal clock frequency to 225kHz. This feature eases the settling-time requirement for the reference voltage. With an external reference, the MAX148/MAX149 can be considered fully powered up within 2µs of actively pulling SHDN high.

Power-Down Sequencing

The MAX148/MAX149 auto power-down modes can save considerable power when operating at less than maximum sample rates. Figures 13, 14a, and 14b show the average supply current as a function of the sampling rate. The following discussion illustrates the various power-down sequences.

Lowest Power at up to 500 Conversions/Channel/Second

The following examples show two different power-down sequences. Other combinations of clock rates, compensation modes, and power-down modes may give lowest power consumption in other applications.

Figure 14a depicts the MAX149 power consumption for one or eight channel conversions utilizing full power-down mode and internal-reference compensation. A 0.01µF bypass capacitor at REFADJ forms an RC filter with the internal $20k\Omega$ reference resistor with a 0.2ms time constant. To achieve full 10-bit accuracy, 8 time constants or 1.6ms are required after power-up. Waiting this 1.6ms in FASTPD mode instead of in full power-up can reduce power consumption by a factor of 10 or more. This is achieved by using the sequence shown in Figure 15.

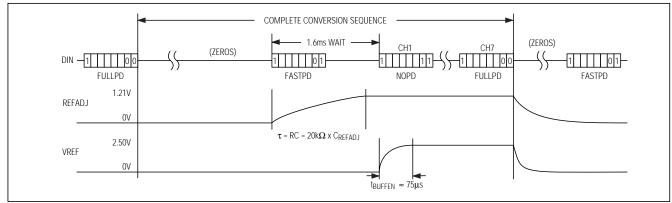


Figure 15. MAX149 FULLPD/FASTPD Power-Up Sequence

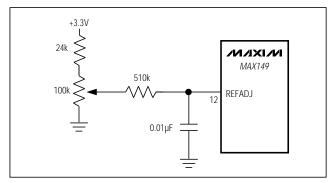


Figure 16. MAX149 Reference-Adjust Circuit

Lowest Power at Higher Throughputs

Figure 14b shows the power consumption with external-reference compensation in fast power-down, with one and eight channels converted. The external 4.7µF compensation requires a 75µs wait after power-up with one dummy conversion. This graph shows fast multi-channel conversion with the lowest power consumption possible. Full power-down mode may provide increased power savings in applications where the MAX148/MAX149 are inactive for long periods of time, but where intermittent bursts of high-speed conversions are required.

Internal and External References

The MAX149 can be used with an internal or external reference voltage, whereas an external reference is required for the MAX148. An external reference can be connected directly at VREF or at the REFADJ pin.

An internal buffer is designed to provide 2.5V at VREF for both the MAX149 and the MAX148. The MAX149's internally trimmed 1.21V reference is buffered with a 2.06 gain. The MAX148's REFADJ pin is also buffered with a 2.00 gain to scale an external 1.25V reference at REFADJ to 2.5V at VREF.

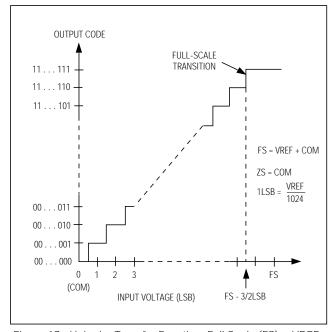


Figure 17. Unipolar Transfer Function, Full Scale (FS) = VREF + COM, Zero Scale (ZS) = COM

Internal Reference (MAX149)

The MAX149's full-scale range with the internal reference is 2.5V with unipolar inputs and ± 1.25 V with bipolar inputs. The internal reference voltage is adjustable to $\pm 1.5\%$ with the circuit in Figure 16.

External Reference

With both the MAX149 and MAX148, an external reference can be placed at either the input (REFADJ) or the output (VREF) of the internal reference-buffer amplifier. The REFADJ input impedance is typically $20k\Omega$ for the MAX149, and higher than $100k\Omega$ for the MAX148. At

Table 7. Full Scale and Zero Scale

UNIPOLAR MODE		BIPOLAR MODE		
Full Scale	Zero Scale	Positive Full Scale	Zero Scale	Negative Full Scale
VREF + COM	СОМ	VREF / 2 + COM	COM	-VREF / 2 + COM

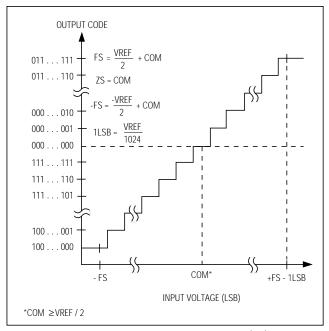


Figure 18. Bipolar Transfer Function, Full Scale (FS) = VREF / 2 + COM, Zero Scale (ZS) = COM

VREF, the DC input resistance is a minimum of $18k\Omega.$ During conversion, an external reference at VREF must deliver up to $350\mu A$ DC load current and have 10Ω or less output impedance. If the reference has a higher output impedance or is noisy, bypass it close to the VREF pin with a $4.7\mu F$ capacitor.

Using the REFADJ input makes buffering the external reference unnecessary. To use the direct VREF input, disable the internal buffer by tying REFADJ to VDD. In power-down, the input bias current to REFADJ is typically 25 μ A (MAX149) with REFADJ tied to VDD. Pull REFADJ to AGND to minimize the input bias current in power-down.

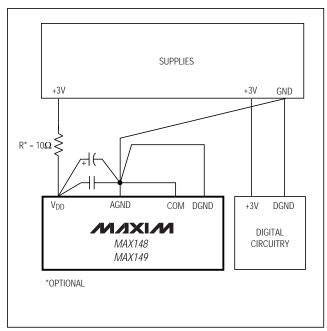


Figure 19. Power-Supply Grounding Connection

Transfer Function

Table 7 shows the full-scale voltage ranges for unipolar and bipolar modes.

The external reference must have a temperature coefficient of 20ppm/°C or less to achieve accuracy to within 1LSB over the 0°C to +70°C commercial temperature range.

Figure 17 depicts the nominal, unipolar input/output (I/O) transfer function, and Figure 18 shows the bipolar input/output transfer function. Code transitions occur halfway between successive-integer LSB values. Output coding is binary, with 1LSB = 2.44mV (2.500V / 1024) for unipolar operation, and 1LSB = 2.44mV [(2.500V / 2 - -2.500V / 2) / 1024] for bipolar operation.

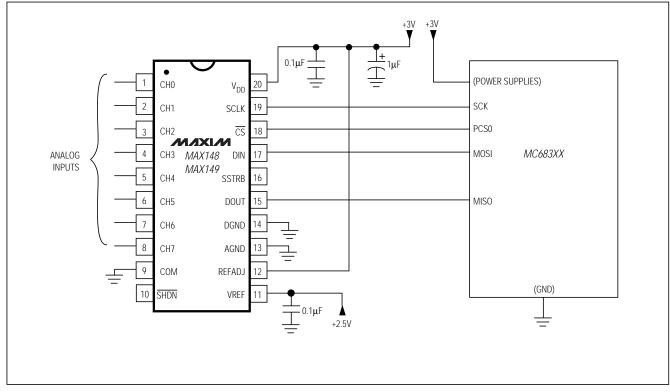


Figure 20. MAX148/MAX149 QSPI Connections, External Reference

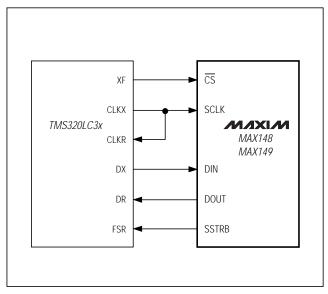


Figure 21. MAX148/MAX149-to-TMS320 Serial Interface

Layout, Grounding, and Bypassing

For best performance, use printed circuit boards. Wire-wrap boards are not recommended. Board layout should ensure that digital and analog signal lines are separated from each other. Do not run analog and digital (especially clock) lines parallel to one another, or digital lines underneath the ADC package.

Figure 19 shows the recommended system ground connections. Establish a single-point analog ground (star ground point) at AGND, separate from the logic ground. Connect all other analog grounds and DGND to the star ground. No other digital system ground should be connected to this ground. For lowest-noise operation, the ground return to the star ground's power supply should be low impedance and as short as possible.

High-frequency noise in the V_{DD} power supply may affect the high-speed comparator in the ADC. Bypass the supply to the star ground with $0.1\mu F$ and $1\mu F$ capacitors close to pin 20 of the MAX148/MAX149. Minimize capacitor lead lengths for best supply-noise rejection. If the power supply is very noisy, a 10Ω resistor can be connected as a lowpass filter (Figure 19).

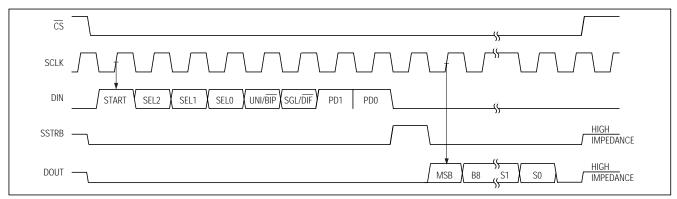


Figure 22. TMS320 Serial-Interface Timing Diagram

High-Speed Digital Interfacing with QSPI

The MAX148/MAX149 can interface with QSPI using the circuit in Figure 20 (fSCLK = 2.0MHz, CPOL = 0, CPHA = 0). This QSPI circuit can be programmed to do a conversion on each of the eight channels. The result is stored in memory without taxing the CPU, since QSPI incorporates its own microsequencer.

The MAX148/MAX149 are QSPI compatible up to the maximum external clock frequency of 2MHz.

TMS320LC3x Interface

Figure 21 shows an application circuit to interface the MAX148/MAX149 to the TMS320 in external clock mode. The timing diagram for this interface circuit is shown in Figure 22.

Use the following steps to initiate a conversion in the MAX148/MAX149 and to read the results:

 The TMS320 should be configured with CLKX (transmit clock) as an active-high output clock and CLKR (TMS320 receive clock) as an active-high input clock. CLKX and CLKR on the TMS320 are tied together with the MAX148/MAX149's SCLK input.

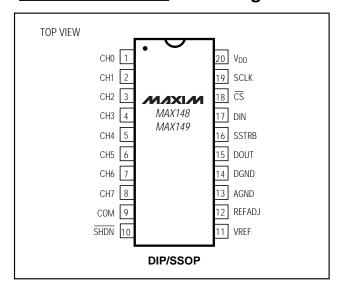
- 2) The MAX148/MAX149's $\overline{\text{CS}}$ pin is driven low by the TMS320's XF_ I/O port to enable data to be clocked into the MAX148/MAX149's DIN.
- 3) An 8-bit word (1XXXXX11) should be written to the MAX148/MAX149 to initiate a conversion and place the device into external clock mode. Refer to Table 1 to select the proper XXXXX bit values for your specific application.
- 4) The MAX148/MAX149's SSTRB output is monitored via the TMS320's FSR input. A falling edge on the SSTRB output indicates that the conversion is in progress and data is ready to be received from the MAX148/MAX149.
- 5) The TMS320 reads in one data bit on each of the next 16 rising edges of SCLK. These data bits represent the 10 + 2-bit conversion result followed by 4 trailing bits, which should be ignored.
- 6) Pull $\overline{\text{CS}}$ high to disable the MAX148/MAX149 until the next conversion is initiated.

Ordering Information (continued)

PART [†]	TEMP. RANGE	PIN-PACKAGE	INL (LSB)
MAX148AEPP	-40°C to +85°C	20 Plastic DIP	±1/2
MAX148BEPP	-40°C to +85°C	20 Plastic DIP	±1
MAX148AEAP	-40°C to +85°C	20 SSOP	±1/2
MAX148BEAP	-40°C to +85°C	20 SSOP	±1
MAX148AMJP	-55°C to +125°C	20 CERDIP*	±1/2
MAX148BMJP	-55°C to +125°C	20 CERDIP*	±1
MAX149ACPP	0°C to +70°C	20 Plastic DIP	±1/2
MAX149BCPP	0°C to +70°C	20 Plastic DIP	±1
MAX149ACAP	0°C to +70°C	20 SSOP	±1/2
MAX149BCAP	0°C to +70°C	20 SSOP	±1
MAX149AEPP	-40°C to +85°C	20 Plastic DIP	±1/2
MAX149BEPP	-40°C to +85°C	20 Plastic DIP	±1
MAX149AEAP	-40°C to +85°C	20 SSOP	±1/2
MAX149BEAP	-40°C to +85°C	20 SSOP	±1
MAX149AMJP	-55°C to +125°C	20 CERDIP*	±1/2
MAX149BMJP	-55°C to +125°C	20 CERDIP*	±1

[†] Contact factory for availability of alternate surface-mount packages.

_Pin Configuration

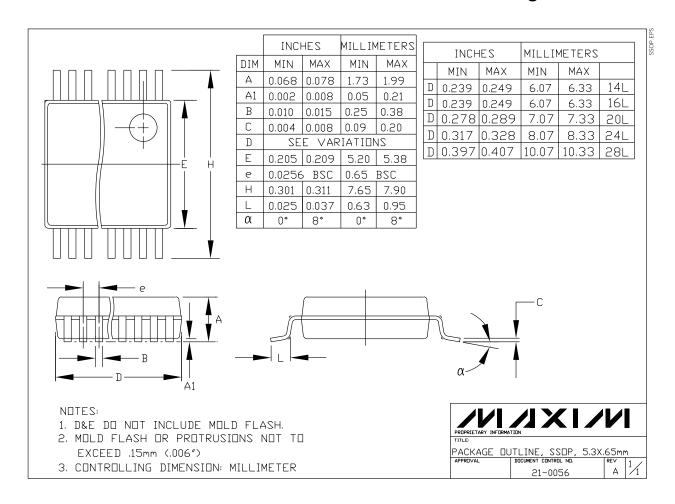


_____Chip Information

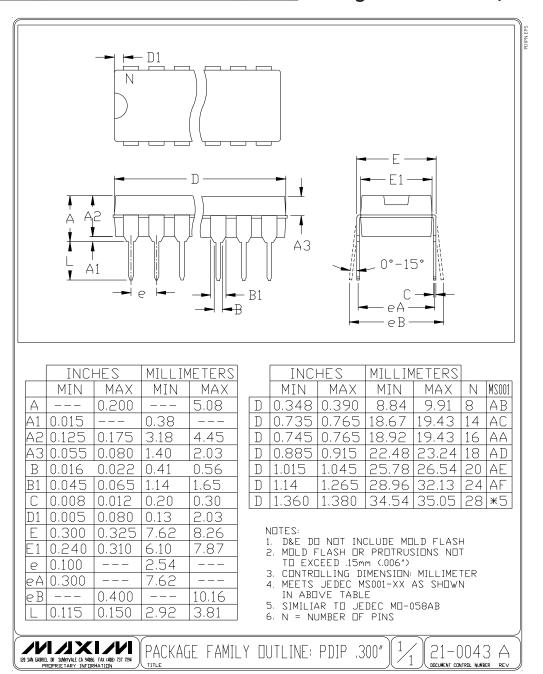
TRANSISTOR COUNT: 2554

 ^{*} Contact factory for availability of CERDIP package, and for processing to MIL-STD-883B.

Package Information



Package Information (continued)



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